**Product data sheet** 

# 1. General description

Dual Silicon Carbide Schottky diode in a TO247-3L plastic package, designed for high frequency switched-mode power supplies.



## 2. Features and benefits

- · Highly stable switching performance
- High forward surge capability I<sub>FSM</sub>
- Extremely fast reverse recovery time
- Superior in efficiency to Silicon Diode alternatives
- · Reduced losses in associated MOSFET
- Reduced EMI
- · Reduced cooling requirements
- RoHS compliant

# 3. Applications

- · Power factor correction
- Telecom / Server SMPS
- UPS
- PV inverter
- PC Silverbox
- LED / OLED TV
- Motor Drives

## 4. Quick reference data

### Table 1. Quick reference data

Symbol	Parameter	Conditions	Values			Unit		
Absolute	maximum rating							
$V_{RRM}$	repetitive peak reverse voltage				650			
I <sub>O(AV)</sub>	limiting average output current	$\delta$ = 0.5 ; T <sub>mb</sub> ≤ 129 °C; square-wave pulse; both diodes conducting; Fig. 1; Fig. 2; Fig. 3	16		A			
T <sub>j</sub>	junction temperature		175			°C		
Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Static ch	aracteristics							
V <sub>F</sub>	forward voltage	I <sub>F</sub> = 8 A; T <sub>j</sub> = 25 °C; per diode; <u>Fig. 5</u>		-	1.5	1.7	V	
		I <sub>F</sub> = 8 A; T <sub>j</sub> = 150 °C; per diode; <u>Fig. 5</u>		-	1.8	2.1	V	
		I <sub>F</sub> = 8 A; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 5</u>		-	1.95	2.25	V	
Dynamic	characteristics					1		
Q <sub>r</sub>	recovered charge	$I_F = 8 \text{ A}$ ; $V_R = 400 \text{ V}$ ; $dI_F/dt = 500 \text{ A/}\mu\text{s}$ ; $T_j = 25 ^{\circ}\text{C}$ ; per diode; Fig. 7		-	19	-	nC	

# 5. Pinning information

**Table 2. Pinning information** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode		
2	K	cathode		A1
3	A2	anode		K
mb	К	mounting base; connected to cathode		sym125

# 6. Ordering information

### **Table 3. Ordering information**

Type number	Package name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WNSC16650CW	TO247	WNSC16650CWQ	Tube	30	TO247N	20-Jul-2016

# 7. Marking

## Table 4. Marking codes

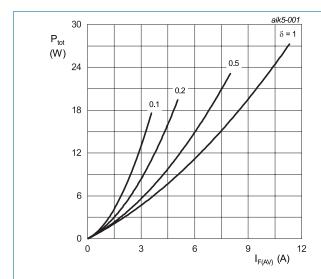
Type number	Marking codes
WNSC16650CW	WNSC 16650CW

# 8. Limiting values

## **Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
$V_{RRM}$	repetitive peak reverse voltage		650	V
$V_{RWM}$	crest working reverse voltage		650	V
$V_R$	reverse voltage	DC	650	V
I <sub>FRM</sub>	repetitive peak forward current	$δ = 0.5$ ; $t_p = 25 \mu s$ ; $T_{mb} \le 129 °C$ ; square-wave pulse; per diode	16	Α
$I_{O(AV)}$	limiting average output current	$\delta$ = 0.5 ; $T_{mb} \le$ 129 °C; square-wave pulse; both diodes conducting; Fig. 1; Fig. 2; Fig. 3	16	А
I <sub>FSM</sub>	non-repetitive peak forward current	$t_p$ = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode	48	А
		$t_p$ = 10 $\mu$ s; $T_{j(init)}$ = 25 °C; square-wave pulse; per diode	385	А
l <sup>2</sup> t	I <sup>2</sup> t for fusing	sine-wave pulse; $T_{j(init)}$ = 25 °C; $t_p$ = 10 ms; per diode	11.5	A <sup>2</sup> s
T <sub>stg</sub>	storage temperature		-55 to 175	°C
T <sub>j</sub>	junction temperature		175	°C



 $I_{F(AV)} = I_{F(RMS)} \times \sqrt{\delta}$   $V_o = 1.249 \text{ V; } R_s = 0.1025 \Omega$ Fig. 1. Forward power dissipation as

Fig. 1. Forward power dissipation as a function of average forward current; square waveform; typical values; per diode

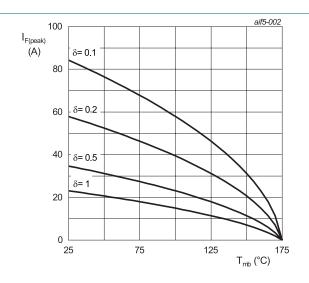
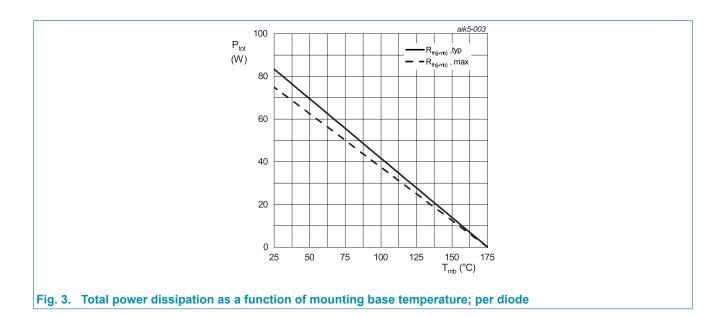


Fig. 2. Current derating as a function of mounting base temperature; per diode



# 9. Thermal characteristics

**Table 6. Thermal characteristics** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance	per diode; Fig. 4	-	1.8	2	K/W
	from junction to mounting base	both diodes conducting	-	0.9	1	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient free air	in free air	-	40	-	K/W

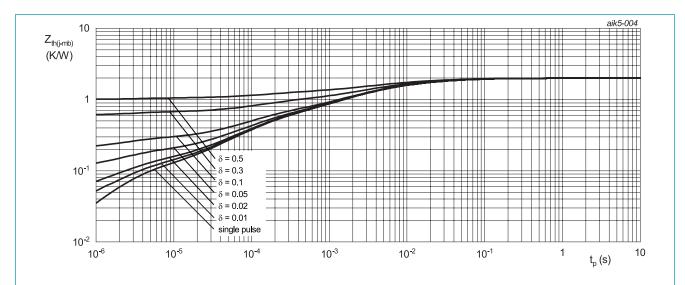
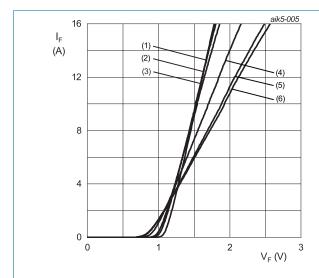


Fig. 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 10. Characteristics

**Table 7. Characteristics** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{F}$	forward current	I <sub>F</sub> = 8 A; T <sub>j</sub> = 25 °C; per diode; <u>Fig. 5</u>	-	1.5	1.7	V
		I <sub>F</sub> = 8 A; T <sub>j</sub> = 150 °C; per diode; <u>Fig. 5</u>	-	1.8	2.1	V
		I <sub>F</sub> = 8 A; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 5</u>	-	1.95	2.25	V
I <sub>R</sub>	reverse current	V <sub>R</sub> = 650 V; T <sub>j</sub> = 25 °C; per diode; <u>Fig. 6</u>	-	-	50	μA
		V <sub>R</sub> = 650 V; T <sub>j</sub> = 175 °C; per diode; <u>Fig. 6</u>	-	-	200	μA
Dynamic	characteristics					
Q <sub>r</sub>	recovered charge	$I_F = 8 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A/µs};$ $T_j = 25 \text{ °C}; \text{ per diode}; \frac{\text{Fig. 7}}{\text{C}}$	-	19	-	nC
C <sub>d</sub>	diode capacitance	f = 1 MHz; V <sub>R</sub> = 1 V; T <sub>j</sub> = 25 °C	-	250	-	pF
		f = 1 MHz; V <sub>R</sub> = 300 V; T <sub>j</sub> = 25 °C	-	31	-	pF
		f = 1 MHz; V <sub>R</sub> = 600 V; T <sub>j</sub> = 25 °C	-	28	-	pF
E <sub>as</sub>	non-repetitive avalanche energy	$I_R = 4.9 \text{ A}$ ; L = 5 mH; $T_{j(init)} = 25 \text{ °C}$	60	-	-	mJ



 $V_o = 1.249 \text{ V}; R_s = 0.1025 \Omega$ 

(1)  $T_j = -55$  °C; typical values

(2) T<sub>i</sub> = 0 °C; typical values

(3)  $T_j = 25$  °C; typical values

(4)  $T_j = 100 \, ^{\circ}\text{C}$ ; typical values

(5) T<sub>j</sub> = 150 °C; typical values

(6) T<sub>i</sub> = 175 °C; typical values

Fig. 5. Forward current as a function of forward voltage; typical values; per diode

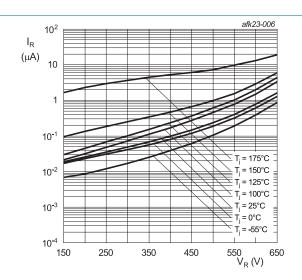
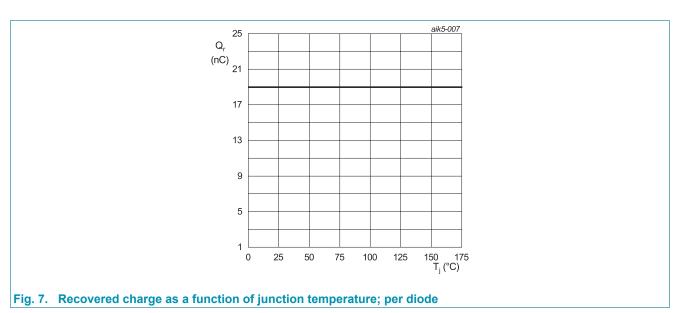
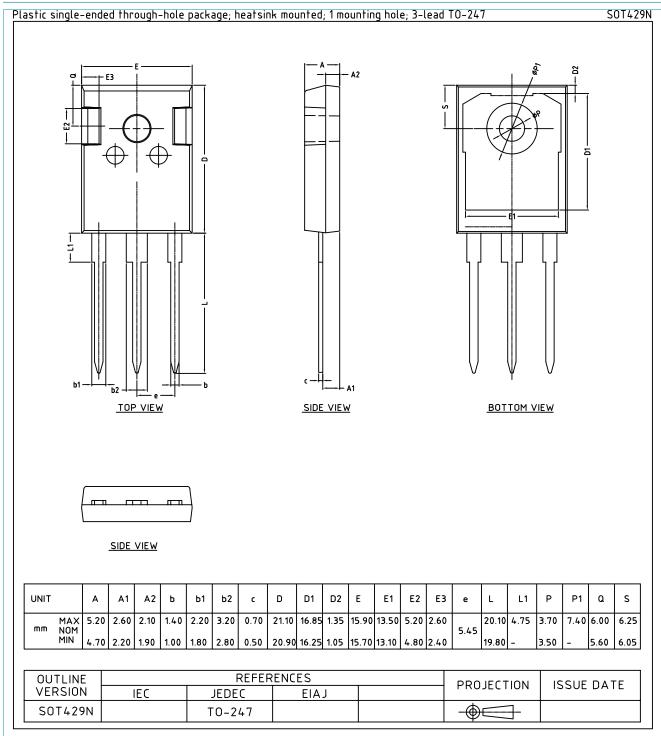


Fig. 6. Reverse leakage current as a function of reverse voltage; typical value; per diode



# 11. Package outline



## 12. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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# 13. Contents

1.	General description	1
2.	Features and benefits	1
3.	Applications	1
4.	Quick reference data	1
5.	Pinning information	2
6.	Ordering information	2
7.	Marking	2
	Limiting values	
	Thermal characteristics	
	). Characteristics	
	. Package outline	
	2. Legal information	
	B. Contents	

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